Search Notes



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10591206	IKEDA, MASAYUKI
Examiner	Art Unit

2618

SEARCHED						
Class	Subclass	Date	Examiner			
455	553.1	03/07/2008	HN			

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SEARCH NOTES			
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EAST search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT;	03/12/2008	HN	
IBM_TDB) (See search history printout report)			
EAST search updated	07/06/2008	HN	

INTERFERENCE SEARCH			
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